# MOSFET - Power, Single P-Channel, SO8-FL

-30 V, 2.7 mΩ, -164 A

# NTMFS005P03P8Z

#### Features

- Ultra Low R<sub>DS(on)</sub> to Improve System Efficiency
- Advanced Package Technology in 5x6mm for Space Saving and Excellent Thermal Conduction
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

## **Typical Applications**

- Power Load Switch
- Protection: Reverse Current, Over Voltage, and Reverse Negative Voltage
- Battery Management

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Parameter			Symbol	Value	Unit		
Drain-to-Source Voltage			V <sub>DSS</sub>	-30	V		
Gate-to-Source Voltage			V <sub>GS</sub>	±25	V		
Continuous Drain		$T_{C} = 25^{\circ}C$	۱ <sub>D</sub>	-164	А		
Current $R_{\theta JC}$ (Note 3)	Steady	$T_C = 85^{\circ}C$		-118			
Power Dissipation $R_{\theta JC}$ (Note 3)	State	T <sub>C</sub> = 25°C	P <sub>D</sub>	104	W		
Continuous Drain Cur-		T <sub>A</sub> = 25°C	Ι <sub>D</sub>	-28.6	А		
rent $R_{\theta JA}$ (Notes 1, 3)	Steady	$T_A = 85^{\circ}C$		-20.6			
Power Dissipation $R_{\theta JA}$ (Notes 1, 3)	State	T <sub>A</sub> = 25°C	PD	3.2	W		
Continuous Drain Cur-	Steady	$T_A = 25^{\circ}C$	I <sub>D</sub>	-15.3	А		
rent $R_{\theta JA}$ (Notes 2, 3)		T <sub>A</sub> = 85°C	1	-11			
Power Dissipation $R_{\theta JA}$ (Notes 2, 3)	State	$T_A = 25^{\circ}C$	PD	0.9	W		
Pulsed Drain Current	Pulsed Drain Current $T_A = 25^{\circ}C, t_p = 10 \ \mu s$			-597	А		
Single Pulse Drain-to-Source Avalanche Energy (I <sub>Lpk</sub> = 57.59 A)			E <sub>AS</sub>	165.8	mJ		
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C		
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

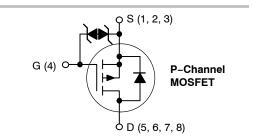
- 1. Surface-mounted on FR4 board using a 1 in<sup>2</sup> pad size, 2 oz. Cu pad.
- 2. Surface-mounted on FR4 board using a minimum pad size, 2 oz. Cu pad.
- 3. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

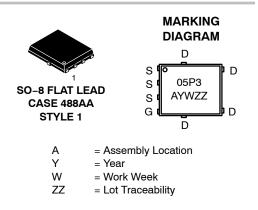


# **ON Semiconductor®**

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	ID
-30 V	2.7 m $\Omega$ @ –10 V	–164 A
-30 v	4.4 mΩ @ -4.5 V	-104 A





### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>		
NTMFS005P03P8ZT1G	SO8-FL	1500 / Tape &		
	(Pb-Free)	Reel		

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain) (Note 1)	$R_{ extsf{ heta}JC}$	1.2	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\thetaJA}$	40	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\thetaJA}$	137	°C/W

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

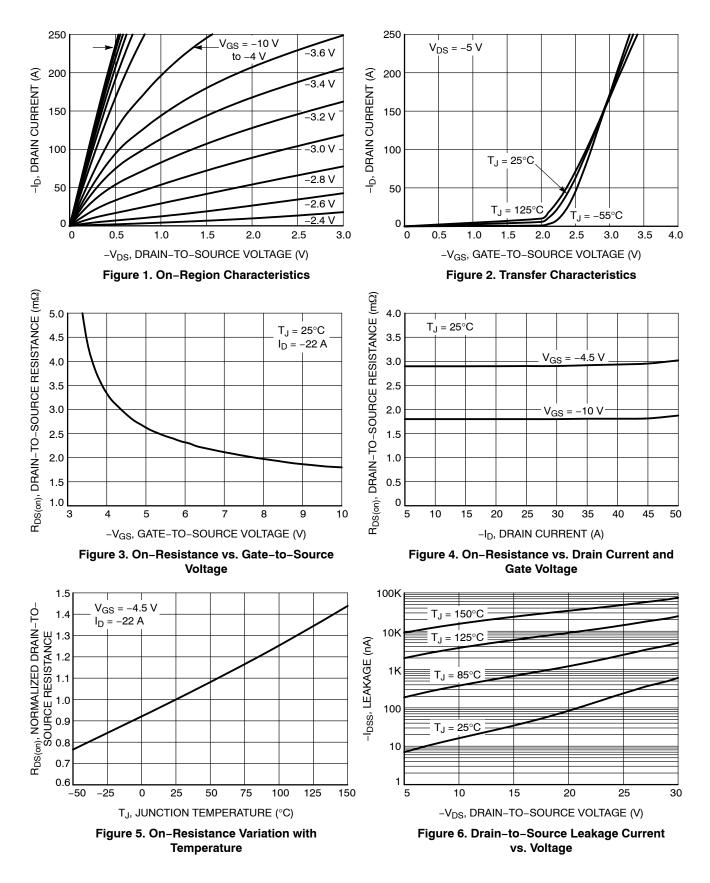
Parameter	Symbol	Test Condition		Min	Тур	Мах	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = -250 $\mu$ A		-30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>	$I_D = -250 \ \mu\text{A}$ , ref to $25^{\circ}\text{C}$			-8.3		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -24 V	T <sub>J</sub> = 25°C			-1.0	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	<sub>3</sub> = ±25 V		1	±10	μΑ
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= –250 μA	-1.0		-3.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	I <sub>D</sub> = –250 μA, r	ef to 25°C		5.3		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -10 V, I <sub>[</sub>	<sub>0</sub> = -22 A		1.8	2.7	mΩ
		V <sub>GS</sub> = -4.5 V, I	<sub>D</sub> = -16 A		2.9	4.4	
Froward Transconductance	9 <sub>FS</sub>	$V_{DS} = -5$ V, $I_{D}$	= -16 A		87		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -15 V, f = 1.0 MHz			7880		pF
Output Capacitance	C <sub>oss</sub>				2630		
Reverse Transfer Capacitance	C <sub>rss</sub>				2550		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -15 \text{ V},$ $I_D = -22 \text{ A}$			112		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				8		]
Gate-to-Source Charge	Q <sub>GS</sub>				16		
Gate-to-Drain Charge	Q <sub>GD</sub>				76		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -10 \text{ V}, \text{ V}_{DS} = -15 \text{ V},$ $I_D = -22 \text{ A}$			183		
SWITCHING CHARACTERISTICS, VG	s = 4.5 V (Note	4)				<b></b>	
Turn–On Delay Time	t <sub>d(on)</sub>				56		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = -4.5 V, V <sub>D</sub>	e = −15 V.		308		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_{\rm D} = -22$ A, R	$_{\rm G} = 6 \Omega$		124		1
Fall Time	t <sub>f</sub>				269		1
SWITCHING CHARACTERISTICS, Vo	as = 10 V (Note 4	4)			•		-
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>GS</sub> = -10 V, V <sub>DS</sub> = -15 V, I <sub>D</sub> = -22 A, R <sub>G</sub> = 6 Ω			22		ns
Rise Time	t <sub>r</sub>				79		
Turn-Off Delay Time	t <sub>d(off)</sub>				220		
Fall Time	t <sub>f</sub>				258		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$		-0.77	-1.3	V
		$I_{\rm S} = -22 {\rm A}$ $T_{\rm J} = 125^{\circ}{\rm C}$			-0.63		1

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

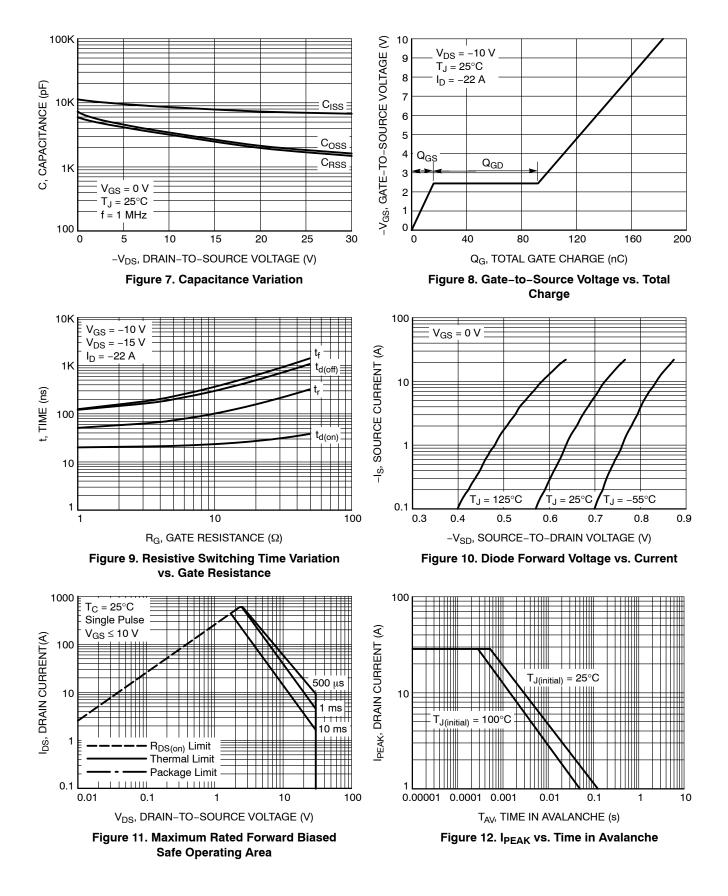
Parameter	Symbol	Test Condition	Min	Тур	Max	Unit	
DRAIN-SOURCE DIODE CHARACTERISTICS							
Reverse Recovery Time	t <sub>RR</sub>			57		ns	
Charge Time	ta	$V_{GS}$ = 0 V, dI_s/dt = 100 A/µs, I_s = -22 A		34			
Discharge Time	t <sub>b</sub>			23			
Reverse Recovery Charge	Q <sub>RR</sub>			77		nC	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

#### **TYPICAL CHARACTERISTICS**



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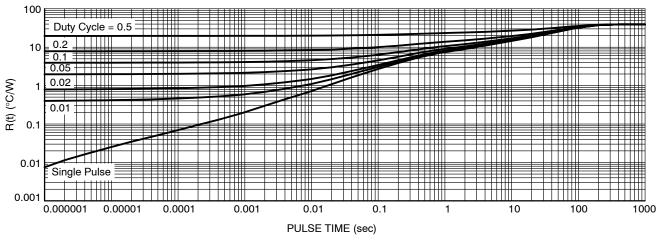
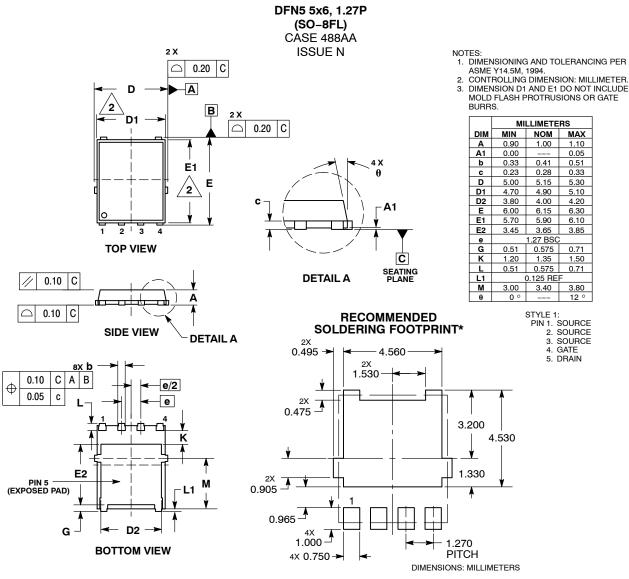


Figure 13. Thermal Characteristics

#### PACKAGE DIMENSIONS



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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